## MC10EL52，MC100EL52

## 5 V ECL Differential Data and Clock D Flip－Flop

## Description

The MC10EL／100EL52 is a differential data，differential clock D flip－flop with reset．The device is functionally equivalent to the E452 device with higher performance capabilities．With propagation delays and output transition times significantly faster than the E452，the EL52 is ideally suited for those applications which require the ultimate in AC performance．

Data enters the master portion of the flip－flop when the clock is LOW and is transferred to the slave，and thus the outputs，upon a positive transition of the clock．The differential clock inputs of the EL52 allow the device to also be used as a negative edge triggered device．

The EL52 employs input clamping circuitry so that under open input conditions（pulled down to $\mathrm{V}_{\mathrm{EE}}$ ）the outputs of the device will remain stable．

The 100 Series contains temperature compensation．

## Features

－ 365 ps Propagation Delay
－ 2.0 GHz Toggle Frequency
－ESD Protection：
－＞ 1 kV Human Body Model
－＞ 100 V Machine Model
－PECL Mode Operating Range： $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$ to 5.7 V
with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
－NECL Mode Operating Range： $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$
with $\mathrm{V}_{\mathrm{EE}}=-4.2 \mathrm{~V}$ to -5.7 V
－Internal Input Pulldown Resistors on D and CLK
－Meets or Exceeds JEDEC Spec EIA／JESD78 IC Latchup Test
－Moisture Sensitivity：
－Level 1 for SOIC－8 NB
－Level 3 for TSSOP－8
－For Additional Information，see Application Note AND8003／D
－Flammability Rating：UL 94 V－0＠ 0.125 in，
Oxygen：Index 28 to 34
－Transistor Count $=48$ Devices
－These Devices are Pb－Free，Halogen Free and are RoHS Compliant

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MARKING DIAGRAMS＊


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HL52

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Y＝Year
W＝Work Week
－＝Pb－Free Package

A＝Assembly Location
be in either location）
（Note：Microdot may be in either location）
For additional marking information，refer to
Application Note AND8002／D．

ORDERING INFORMATION

| Device | Package | Shipping $\dagger$ |
| :--- | :---: | :---: |
| MC10EL52DG | SOIC－8 NB <br> （Pb－Free） | 98 Units／Tube |
| MC10EL52DR2G | SOIC－8 NB <br> （Pb－Free） | 2500 Tape \＆Reel |
| MC10EL52DTG | TSSOP－8 <br> （Pb－Free） | 100 Units／Tube |
| MC100EL52DG | SOIC－8 NB <br> （Pb－Free） | 48 Units／Tube |
| MC100EL52DR2G | SOIC－8 NB <br> （Pb－Free） | 2500 Tape \＆Reel |

$\dagger$ For information on tape and reel specifications，in－ cluding part orientation and tape sizes，please refer to our Tape and Reel Packaging Specifications Brochure，BRD8011／D．


Figure 1. Logic Diagram and Pinout Assignment

Table 1. TRUTH TABLE

| $\mathbf{D}^{*}$ | CLK $^{*}$ | $\mathbf{Q}$ |
| :---: | :---: | :---: |
| L | Z | L |
| $H$ | $Z$ | $H$ |

Z = LOW to HIGH Transition

* Pin will default low when left open.

Table 2. PIN DESCRIPTION

| PIN | FUNCTION |
| :--- | :--- |
| D, $\bar{D}$ | ECL Data Input |
| CLK, CLK | ECL Clock Input |
| $\mathrm{Q}, \overline{\mathrm{Q}}$ | ECL Data Output |
| $\mathrm{V}_{\mathrm{CC}}$ | Positive Supply |
| $\mathrm{V}_{\mathrm{EE}}$ | Negative Supply |

Table 3. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 8 | V |
| $\mathrm{V}_{\mathrm{EE}}$ | NECL Mode Power Supply | $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$ |  | -8 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & V_{E E}=0 V \\ & V_{C C}=0 V \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{1} \leq \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{~V}_{1} \geq \mathrm{V}_{\mathrm{EE}} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | V |
| $\mathrm{I}_{\text {out }}$ | Output Current | Continuous Surge |  | $\begin{gathered} 50 \\ 100 \end{gathered}$ | mA |
| $\mathrm{T}_{\text {A }}$ | Operating Temperature Range |  |  | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\mathrm{JA}}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{aligned} & 0 \text { lfpm } \\ & 500 \text { lfpm } \end{aligned}$ | $\begin{aligned} & \text { SOIC-8 NB } \\ & \text { SOIC-8 NB } \end{aligned}$ | $\begin{aligned} & \hline 190 \\ & 130 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\mathrm{Jc}}$ | Thermal Resistance (Junction-to-Case) | Standard Board | SOIC-8 NB | 41 to 44 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{aligned} & \hline 0 \text { lfpm } \\ & 500 \text { lfpm } \end{aligned}$ | $\begin{aligned} & \hline \text { TSSOP-8 } \\ & \text { TSSOP-8 } \end{aligned}$ | $\begin{aligned} & 185 \\ & 140 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\mathrm{Jc}}$ | Thermal Resistance (Junction-to-Case) | Standard Board | TSSOP-8 | 41 to $44 \pm 5 \%$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{T}_{\text {sol }}$ | Wave Solder (Pb-Free) | < 2 to 3 sec @ $260^{\circ} \mathrm{C}$ |  | 265 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

Table 4. 10EL SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; \mathrm{V}_{E E}=0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $I_{\text {EE }}$ | Power Supply Current |  | 21 | 25 |  | 21 | 25 |  | 21 | 25 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3920 | 4010 | 4110 | 4020 | 4105 | 4190 | 4090 | 4185 | 4280 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3050 | 3200 | 3350 | 3050 | 3210 | 3370 | 3050 | 3227 | 3405 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 3770 |  | 4110 | 3870 |  | 4190 | 3940 |  | 4280 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | 3050 |  | 3500 | 3050 |  | 3520 | 3050 |  | 3555 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) D CLK | $\begin{aligned} & 3.4 \\ & 2.5 \end{aligned}$ |  | $\begin{aligned} & 4.6 \\ & 4.4 \end{aligned}$ | $\begin{aligned} & 3.4 \\ & 2.5 \end{aligned}$ |  | $\begin{aligned} & 4.6 \\ & 4.4 \end{aligned}$ | $\begin{aligned} & 3.4 \\ & 2.5 \end{aligned}$ |  | $\begin{aligned} & 4.6 \\ & 4.4 \end{aligned}$ | V |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| $I_{\text {IL }}$ | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.3 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.
$\mathrm{V}_{\mathrm{EE}}$ can vary $+0.25 \mathrm{~V} /-0.5 \mathrm{~V}$ for $+25^{\circ} \mathrm{C}$ and $+85^{\circ} \mathrm{C}$. or $\mathrm{V}_{\mathrm{EE}}$ can vary $+0.06 \mathrm{~V} /-0.5 \mathrm{~V}$ for $-40^{\circ} \mathrm{C}$.
2. Outputs are terminated through a 50 ohm resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{I H C M R}$ min varies $1: 1$ with $\mathrm{V}_{E E}, \mathrm{~V}_{\text {IHCMR }}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\text {IHCMR }}$ range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between $\mathrm{V}_{\mathrm{PP}}$ min and 1 V .

Table 5. 10EL SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}\right.$ (Note 1))

|  | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Symbol |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\mathrm{EE}}$ | Power Supply Current |  | 21 | 25 |  | 21 | 25 |  | 21 | 25 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1080 | -990 | -890 | -980 | -895 | -810 | -910 | -815 | -720 | mV |
| $\mathrm{V}_{\mathrm{OL}}$ | Output LOW Voltage (Note 2) | -1950 | -1800 | -1650 | -1950 | -1790 | -1630 | -1950 | -1773 | -1595 | mV |
| $\mathrm{V}_{\text {IH }}$ | Input HIGH Voltage (Single-Ended) | -1230 |  | -890 | -1130 |  | -810 | -1060 |  | -720 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | -1950 |  | -1500 | -1950 |  | -1480 | -1950 |  | -1445 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) D CLK | $\begin{aligned} & -1.6 \\ & -2.5 \end{aligned}$ |  | $\begin{aligned} & -0.4 \\ & -0.6 \end{aligned}$ | $\begin{aligned} & -1.6 \\ & -2.5 \end{aligned}$ |  | $\begin{aligned} & -0.4 \\ & -0.6 \end{aligned}$ | $\begin{aligned} & -1.6 \\ & -2.5 \end{aligned}$ |  | $\begin{aligned} & -0.4 \\ & -0.6 \end{aligned}$ | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.3 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$.
$\mathrm{V}_{\mathrm{EE}}$ can vary $+0.25 \mathrm{~V} /-0.5 \mathrm{~V}$ for $+25^{\circ} \mathrm{C}$ and $+85^{\circ} \mathrm{C}$. or $\mathrm{V}_{\mathrm{EE}}$ can vary $+0.06 \mathrm{~V} /-0.5 \mathrm{~V}$ for $-40^{\circ} \mathrm{C}$.
2. Outputs are terminated through a 50 ohm resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $V_{I H C M R}$ min varies $1: 1$ with $V_{E E}, V_{I H C M R}$ max varies $1: 1$ with $V_{C C}$. The $V_{I H C M R}$ range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between $\mathrm{V}_{\mathrm{Pp}}$ min and 1 V .

Table 6. 100EL SERIES PECL DC CHARACTERISTICS (VCC $=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 21 | 25 |  | 21 | 25 |  | 24 | 29 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3915 | 3995 | 4120 | 3975 | 4045 | 4120 | 3975 | 4050 | 4120 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3170 | 3305 | 3445 | 3190 | 3295 | 3380 | 3190 | 3295 | 3380 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | 3835 |  | 4120 | 3835 |  | 4120 | 3835 |  | 4120 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | 3190 |  | 3525 | 3190 |  | 3525 | 3190 |  | 3525 | mV |
| VIHCMR | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) D CLK | $\begin{aligned} & 2.6 \\ & 2.5 \end{aligned}$ |  | $\begin{aligned} & 4.6 \\ & 4.2 \end{aligned}$ | $\begin{aligned} & 2.6 \\ & 2.5 \end{aligned}$ |  | $\begin{aligned} & 4.6 \\ & 4.2 \end{aligned}$ | $\begin{aligned} & 2.6 \\ & 2.5 \end{aligned}$ |  | $\begin{aligned} & 4.6 \\ & 4.2 \end{aligned}$ | V |
| IIH | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}} . \mathrm{V}_{\mathrm{EE}}$ can vary $+0.8 \mathrm{~V} /-0.5 \mathrm{~V}$.
2. Outputs are terminated through a 50 ohm resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\text {IHCMR }}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\text {IHCMR }}$ range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between $\mathrm{V}_{\text {PP }}$ min and 1 V .

Table 7. 100EL SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 21 | 25 |  | 21 | 25 |  | 24 | 29 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1085 | -1005 | -880 | -1025 | -955 | -880 | -1025 | -955 | -880 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1830 | -1695 | -1555 | -1810 | -1705 | -1620 | -1810 | -1705 | -1620 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage (Single-Ended) | -1165 |  | -880 | -1165 |  | -880 | -1165 |  | -880 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage (Single-Ended) | -1810 |  | -1475 | -1810 |  | -1475 | -1810 |  | -1475 | mV |
| $\mathrm{V}_{\text {IHCMR }}$ | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) D CLK | $\begin{aligned} & -2.4 \\ & -2.5 \end{aligned}$ |  | $\begin{aligned} & -0.4 \\ & -0.8 \end{aligned}$ | $\begin{aligned} & -2.4 \\ & -2.5 \end{aligned}$ |  | $\begin{aligned} & -0.4 \\ & -0.8 \end{aligned}$ | $\begin{aligned} & -2.4 \\ & -2.5 \end{aligned}$ |  | $\begin{aligned} & -0.4 \\ & -0.8 \end{aligned}$ | V |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 |  |  | 0.5 |  |  | 0.5 |  |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm . Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $+0.8 \mathrm{~V} /-0.5 \mathrm{~V}$.
2. Outputs are terminated through a 50 ohm resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.
3. $\mathrm{V}_{\text {IHCMR }}$ min varies $1: 1$ with $\mathrm{V}_{\text {EE }}, \mathrm{V}_{\text {IHCMR }}$ max varies $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. The $\mathrm{V}_{\mathrm{IHCMR}}$ range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between $\mathrm{V}_{\text {PPmin }}$ and 1 V .

Table 8. AC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CC}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}\right.$ or $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $-40^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| fmax | Maximum Toggle Frequency | 1.8 | 2.5 |  | 2.2 | 2.8 |  | 2.2 | 2.8 |  | GHz |
| $\begin{aligned} & \hline \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation Delay to Output CLK | 225 | 335 | 515 | 275 | 365 | 465 | 320 | 410 | 510 | ps |
| ts | Setup Time | 125 | 0 |  | 125 | 0 |  | 125 | 0 |  | ps |
| $\mathrm{t}_{\mathrm{H}}$ | Hold Time | 150 | 50 |  | 150 | 50 |  | 150 | 50 |  | ps |
| tpW | Minimum Pulse Width | 400 |  |  | 400 |  |  | 400 |  |  | ps |
| $\mathrm{V}_{\mathrm{PP}}$ | Input Swing (Note 2) | 150 |  | 1000 | 150 |  | 1000 | 150 |  | 1000 | mV |
| $\mathrm{t}_{\text {JITTER }}$ | Cycle-to-Cycle Jitter |  | TBD |  |  | TBD |  |  | TBD |  | ps |
| $\mathrm{t}_{\mathrm{r}}$ $\mathrm{t}_{\mathrm{f}}$ | Output Rise/Fall Times Q (20\%-80\%) | 100 | 225 | 350 | 100 | 225 | 350 | 100 | 225 | 350 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. 10 Series: $\mathrm{V}_{\mathrm{EE}}$ can vary $+0.25 \mathrm{~V} /-0.5 \mathrm{~V}$ for $+25^{\circ} \mathrm{C}$ and $+85^{\circ} \mathrm{C}$. or $\mathrm{V}_{\mathrm{EE}}$ can vary $+0.06 \mathrm{~V} /-0.5 \mathrm{~V}$ for $-40^{\circ} \mathrm{C}$ 100 Series: $V_{E E}$ can vary $+0.8 \mathrm{~V} /-0.5 \mathrm{~V}$.
2. $\mathrm{V}_{\mathrm{PP}(\mathrm{min})}$ is minimum input swing for which AC parameters guaranteed. The device has a DC gain of $\approx 40$.

## MC10EL52, MC100EL52



Figure 2. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices)

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V)
AN1503/D - ECLinPS $^{\text {M }}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family $^{\text {AN1568/D }}-$ Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

## MC10EL52, MC100EL52

## PACKAGE DIMENSIONS

SOIC-8 NB
D SUFFIX CASE 751-07
ISSUE AK


NOTES:
. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982
. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR
PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION
6. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

|  | MILLIMETERS |  | INCHES |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |  |  |
| A | 4.80 | 5.00 | 0.189 | 0.197 |  |  |
| B | 3.80 | 4.00 | 0.150 | 0.157 |  |  |
| C | 1.35 | 1.75 | 0.053 | 0.069 |  |  |
| D | 0.33 | 0.51 | 0.013 | 0.020 |  |  |
| G | 1.27 |  | BSC | 0.050 |  | BSC |
| H | 0.10 | 0.25 | 0.004 | 0.010 |  |  |
| $\mathbf{J}$ | 0.19 | 0.25 | 0.007 | 0.010 |  |  |
| $\mathbf{K}$ | 0.40 | 1.27 | 0.016 | 0.050 |  |  |
| $\mathbf{M}$ | $0{ }^{\circ}$ | $8{ }^{\circ}$ | 0 | 0 |  |  |
| $\mathbf{N}$ | 0.25 | 0.50 | 0.010 | 0.020 |  |  |
| $\mathbf{S}$ | 5.80 | 6.20 | 0.228 | 0.244 |  |  |

## SOLDERING FOOTPRINT*


*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## PACKAGE DIMENSIONS

TSSOP-8
DT SUFFIX
CASE 948R-02
ISSUE A


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILIMETER
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS. MOLD FLE
OR GATE BURRS SHALL NOT EXCEED 0.15 OR GATE BURRS
(0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
6. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-

|  | MILLIMETERS |  | INCHES |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DIM | MIN | MAX | MIN | MAX |  |  |
| A | 2.90 | 3.10 | 0.114 | 0.122 |  |  |
| B | 2.90 | 3.10 | 0.114 | 0.122 |  |  |
| C | 0.80 | 1.10 | 0.031 | 0.043 |  |  |
| D | 0.05 | 0.15 | 0.002 | 0.006 |  |  |
| F | 0.40 | 0.70 | 0.016 | 0.028 |  |  |
| G | 0.65 BSC |  | 0.026 BSC |  |  |  |
| K | 0.25 |  | 0.40 | 0.010 |  | 0.016 |
| L | 4.90 BSC |  | 0.193 BSC |  |  |  |
| M | $0^{\circ}$ |  | $66^{\circ}$ | $0^{\circ}$ |  | $6^{\circ}$ |

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